

AUG 27 2003

INFORMATION DISCLOSURE
CITATION

Atty. Docket No.

Serial No.

4329,2620

09/923,443

Applicant

Nomura et al.

Filing Date

Group

August 8, 2001

Unknown

U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Sub- Class	Filing Date

FOREIGN PATENT DOCUMENTS

*Examiner Initial	Document Number	Date	Country	Class	Sub- Class	Translation	
						Yes	No
	11-237310	8/31/99	Japan				XX

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

DBE	Kirk, "Astigmatism and field curvature from pin-bars," March 6-8, 1991, SPIE, 1463:282-291

Examiner

Date Considered

P. B. M. F. S.

6/23/03

- * Examiner: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.



PATENT
Attorney Docket No.: 4329.2620

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

HIROSHI NOMURA ET AL.

Serial No.: 09/923,443

Group Art Unit: Unknown

Filed: August 8, 2001

Examiner: Unknown

For: EVALUATION MASK, FOCUS
MEASURING METHOD AND
ABERRATION MEASURING
METHOD

**INFORMATION DISCLOSURE STATEMENT
UNDER 37 C.F.R. § 1.97(b)**

Assistant Commissioner for Patents
Washington, D.C. 20231

Sir:

Pursuant to 37 C.F.R. §§ 1.56 and 1.97(b), Applicants bring to the attention of the Examiner the documents listed on the attached PTO 1449. This Information Disclosure Statement is being filed within three months of the filing date of the above-referenced application.

Copies of the listed documents are attached.

Applicants respectfully request that the Examiner consider the listed documents and indicate that they were considered by making appropriate notations on the attached form.

Following is a concise statement of relevance of the non-English language document:

Japanese Publication No. 11-237310 is discussed at page 28, lines 23-27, of the present application.

This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that each or all of the listed documents are material or constitute "prior art." If the Examiner applies any of the documents as prior art against any claim in the application and Applicants determine that the cited documents do not constitute "prior art" under U.S. law, Applicants reserve the right to present to the Patent Office the relevant facts and law regarding the appropriate status of such documents.

Applicants further reserve the right to take appropriate action to establish the patentability of the claimed invention over the listed documents, should one or more of the documents be applied against the claims of the present application.

If there is any fee due in connection with the filing of this Statement, please charge the fee to our Deposit Account No. 06-0916.

Respectfully submitted,

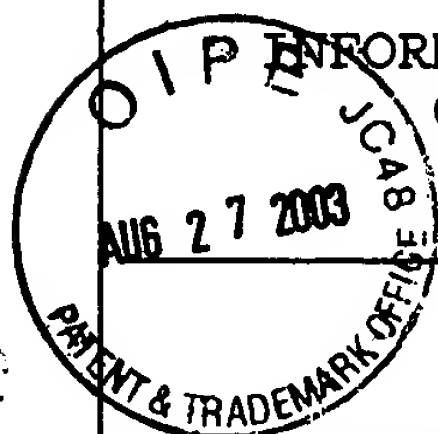
FINNEGAN, HENDERSON, FARABOW,
GARRETT & DUNNER, L.L.P.

Date:

8/29/01

By:

Richard V. Burgujian
Registration No. 31,744



OIP INFORMATION DISCLOSURE CITATION	Atty. Docket No.	Serial No.
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